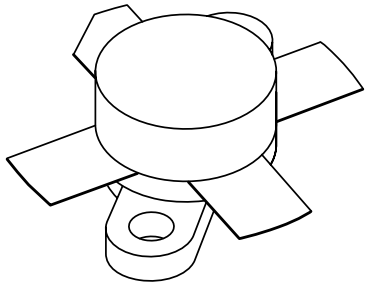
DATA SHEET



BLF147
VHF power MOS transistor

Product specification
Supersedes data of 2001 May 23

2003 Sep 01

Philips
Semiconductors

PHILIPS

VHF power MOS transistor BLF147

FEATURES

- High power gain
- Low intermodulation distortion
- Easy power control
- Good thermal stability
- Withstands full load mismatch.

APPLICATIONS

- Industrial and military applications in the HF/VHF frequency range.

DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS transistor encapsulated in a 4-lead, SOT121B flange package with a ceramic cap. All leads are isolated from the flange. A marking code, showing gate-source voltage (V_{GS}) information is provided for matched pair applications. Refer to the “General” section of the handbook for further information.

CAUTION
This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

PINNING - SOT121B

PIN	DESCRIPTION
1	drain
2	source
3	gate
4	source

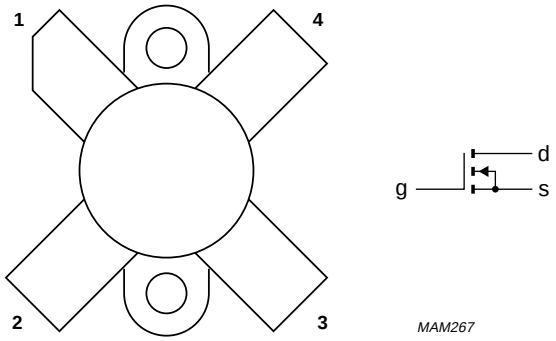


Fig.1 Simplified outline and symbol.

QUICK REFERENCE DATA

RF performance at T_h = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V_{DS} (V)	P_L (W)	G_p (dB)	η_D (%)	d_3 (dB)	d_5 (dB)
SSB, class-AB	28	28	150 (PEP)	>17	>35	<–30	<–30
CW, class-B	108	28	150	typ. 14	typ. 70	–	–

WARNING
Product and environmental safety - toxic materials
This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

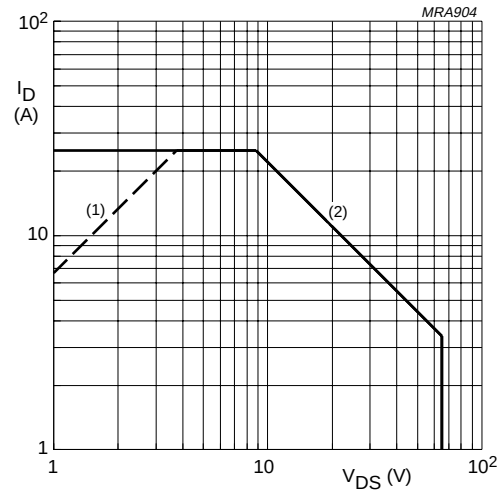
LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	drain-source voltage		–	65	V
V_{GS}	gate-source voltage		–	±20	V
I_D	drain current (DC)		–	25	A
P_{tot}	total power dissipation	$T_{mb} \leq 25$ °C	–	220	W
T_{stg}	storage temperature		−65	150	°C
T_j	junction temperature		–	200	°C

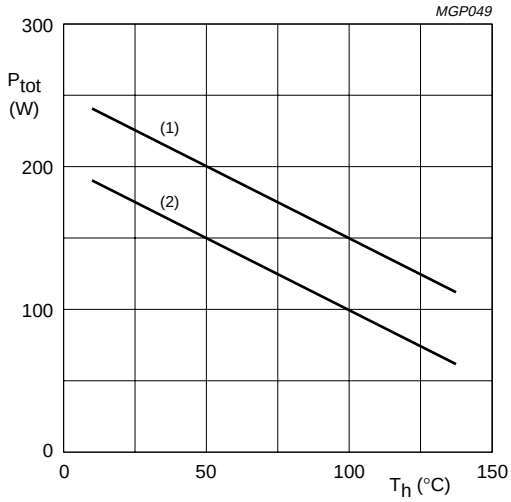
THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j\text{-}mb}$	thermal resistance from junction to mounting base	0.8	K/W
$R_{th\ mb\text{-}h}$	thermal resistance from mounting base to heatsink	0.2	K/W



(1) Current is this area may be limited by R_{DSon}.
(2) T_{mb} = 25 °C.

Fig.2 DC SOAR.



(1) Short-time operation during mismatch.
(2) Continuous operation.

Fig.3 Power derating curves.

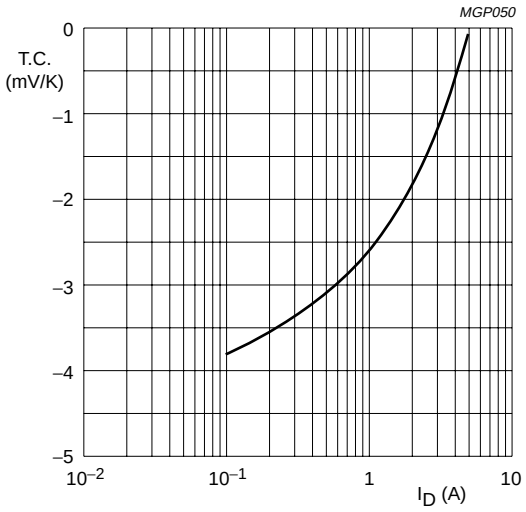
CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 100 mA; V_{GS} = 0	65	–	–	V
I_{DSS}	drain-source leakage current	V_{GS} = 0; V_{DS} = 28 V	–	–	5	mA
I_{GSS}	gate-source leakage current	V_{GS} = ±20 V; V_{DS} = 0	–	–	1	μA
V_{GSth}	gate-source threshold voltage	I_D = 200 mA; V_{DS} = 10 V	2	–	4.5	V
ΔV_{GS}	gate-source voltage difference of matched pairs	I_D = 100 mA; V_{DS} = 10 V	–	–	100	mV
g_{fs}	forward transconductance	I_D = 8 A; V_{DS} = 10 V	5	7.5	–	S
R_{DSon}	drain-source on-state resistance	I_D = 8 A; V_{GS} = 10 V	–	0.1	0.15	Ω
I_{DSX}	on-state drain current	V_{GS} = 10 V; V_{DS} = 10 V	–	37	–	A
C_{is}	input capacitance	V_{GS} = 0; V_{DS} = 28 V; f = 1 MHz	–	450	–	pF
C_{os}	output capacitance	V_{GS} = 0; V_{DS} = 28 V; f = 1 MHz	–	360	–	pF
C_{rs}	feedback capacitance	V_{GS} = 0; V_{DS} = 28 V; f = 1 MHz	–	55	–	pF

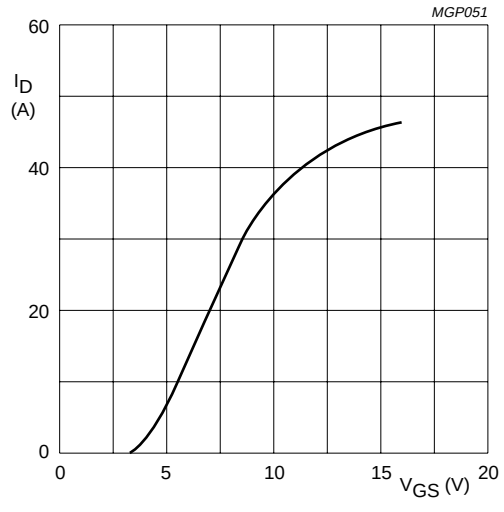
V_{GS} group indicator

GROUP	LIMITS (V)		GROUP	LIMITS (V)	
	MIN.	MAX.		MIN.	MAX.
A	2.0	2.1	O	3.3	3.4
B	2.1	2.2	P	3.4	3.5
C	2.2	2.3	Q	3.5	3.6
D	2.3	2.4	R	3.6	3.7
E	2.4	2.5	S	3.7	3.8
F	2.5	2.6	T	3.8	3.9
G	2.6	2.7	U	3.9	4.0
H	2.7	2.8	V	4.0	4.1
J	2.8	2.9	W	4.1	4.2
K	2.9	3.0	X	4.2	4.3
L	3.0	3.1	Y	4.3	4.4
M	3.1	3.2	Z	4.4	4.5
N	3.2	3.3			



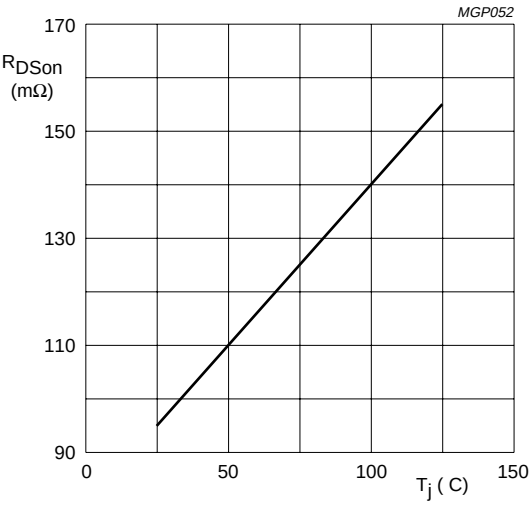
V_{DS} = 28 V; valid for T_h = 25 to 70 °C.

Fig.4 Temperature coefficient of gate-source voltage as a function of drain current; typical values.



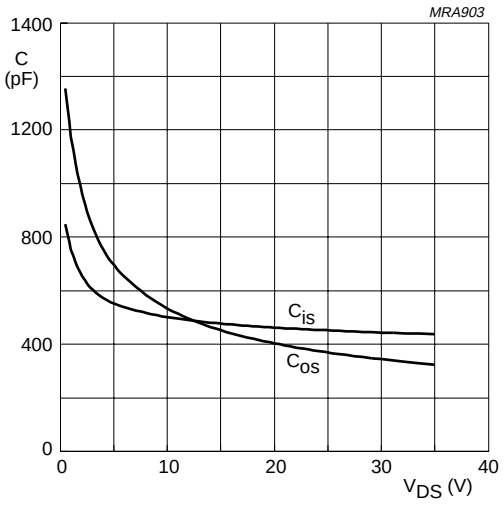
V_{DS} = 10 V.

Fig.5 Drain current as a function of gate-source voltage; typical values.



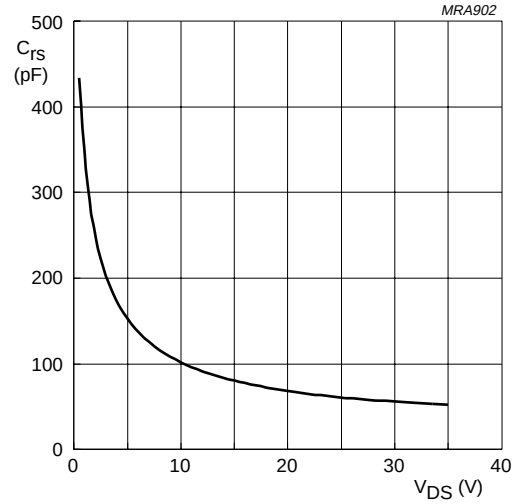
I_D = 8 A; V_{GS} = 10 V.

Fig.6 Drain-source on-state resistance as a function of junction temperature; typical values.



V_{GS} = 0; f = 1 MHz.

Fig.7 Input and output capacitance as functions of drain-source voltage; typical values.



V_{GS} = 0; f = 1 MHz.

Fig.8 Feedback capacitance as a function of drain-source voltage; typical values.

APPLICATION INFORMATION FOR CLASS-AB OPERATION

RF performance in SSB operation in a common source class-AB circuit.
T_h = 25 °C; $R_{th\ mb\text{-}h}$ = 0.2 K/W; R_{GS} = 9.8 Ω; f_1 = 28.000 MHz; f_2 = 28.001 MHz; unless otherwise specified.

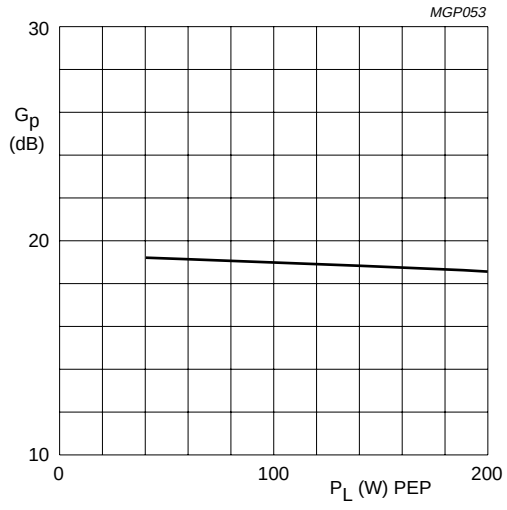
P_L (W)	f (MHz)	V_{DS} (V)	I_{DQ} (A)	G_p (dB)	η_D (%)	d_3 (dB) (note 2)	d_5 (dB) (note 2)
20 to 150 (PEP)	28	28	1	>17 typ. 19	>35 typ. 40	<–30 typ. –34	<–30 typ. –40

Notes

1. Optimum load impedance: 2.1 + j0 Ω.
2. Maximum values at drive levels within the specified PEP values for either amplified tone. For the peak envelope power the values should be decreased by 6 dB.

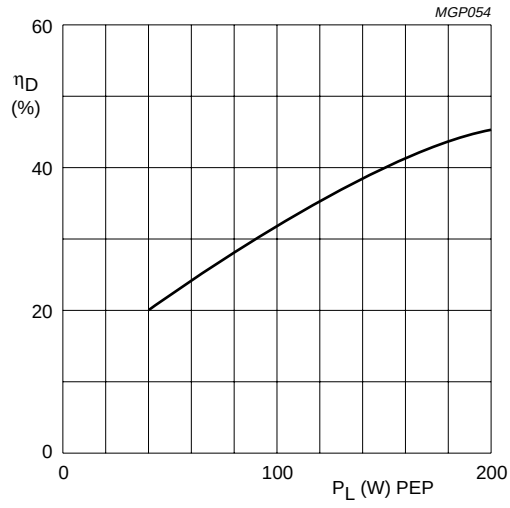
Ruggedness in class-AB operation

The BLF147 is capable of withstanding a load mismatch corresponding to VSWR = 50:1 through all phases under the following conditions: V_{DS} = 28 V; f = 28 MHz at rated load power.



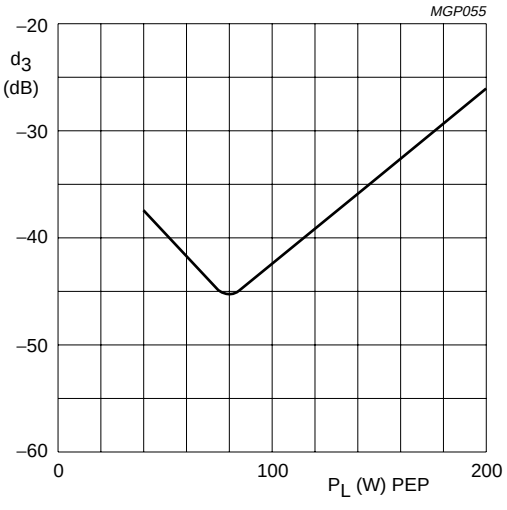
Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 9.8 Ω; f_1 = 28.000 MHz; f_2 = 28.001 MHz.

Fig.9 Power gain as a function of load power; typical values.



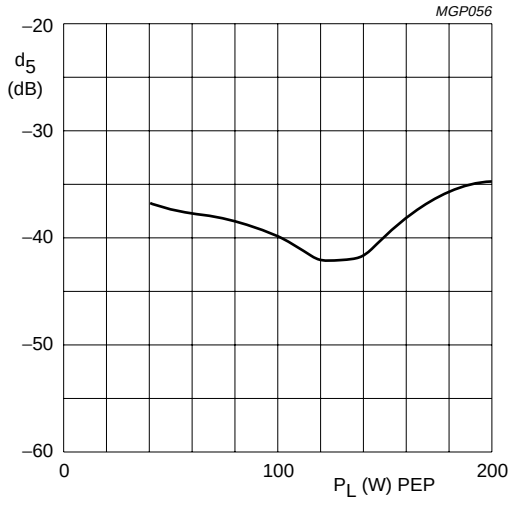
Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 9.8 Ω; f_1 = 28.000 MHz; f_2 = 28.001 MHz.

Fig.10 Efficiency as a function of load power; typical values.



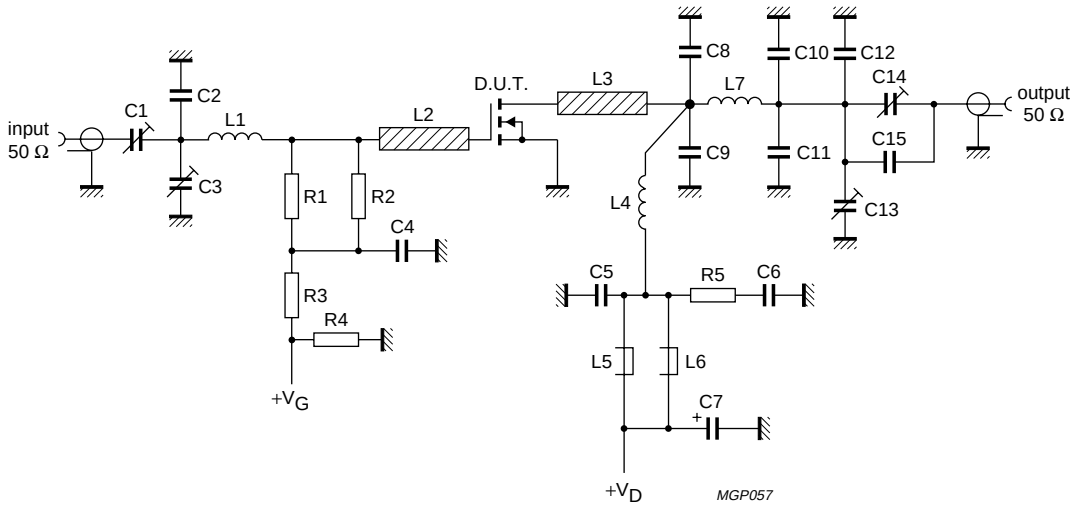
Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 9.8 Ω; f_1 = 28.000 MHz; f_2 = 28.001 MHz.

Fig.11 Third order intermodulation distortion as a function of load power; typical values.



Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 9.8 Ω; f_1 = 28.000 MHz; f_2 = 28.001 MHz.

Fig.12 Fifth order intermodulation distortion as a function of load power; typical values.



f = 28 MHz.

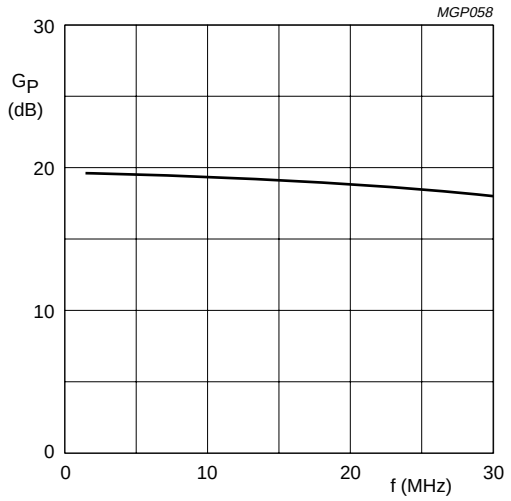
Fig.13 Test circuit for class-AB operation.

List of components (see Fig 13)**.**

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C3, C13, C14	film dielectric trimmer	7 to 100 pF		2222 809 07015
C2, C8, C9	multilayer ceramic chip capacitor; note 1	75 pF		
C4, C5	multilayer ceramic chip capacitor	100 nF		2222 852 47104
C6	multilayer ceramic chip capacitors in parallel	3×100 nF		2222 852 47104
C7	electrolytic capacitor	2.2 μF, 63 V		
C10	multilayer ceramic chip capacitor; note 1	100 pF		
C11, C12	multilayer ceramic chip capacitor; note 1	150 nF		
C15	multilayer ceramic chip capacitor; note 1	240 pF		
L1	6 turns enamelled 0.7 mm copper wire	145 nH	length 5 mm; int. dia. 6 mm; leads 2×5 mm	
L2, L3	stripline; note 2	41.1 Ω	length 13×6 mm	
L4	4 turns enamelled 1.5 mm copper wire	148 nH	length 8 mm; int. dia. 10 mm; leads 2×5 mm	
L5, L6	grade 3B Ferroxcube wideband HF choke			4312 020 36642
L7	3 turns enamelled 2.2 mm copper wire	79 nH	length 8 mm; int. dia. 8 mm; leads 2×5 mm	
R1, R2	1 W metal film resistor	19.6 Ω		2322 153 51969
R3	0.4 W metal film resistor	10 kΩ		2322 151 71003
R4	0.4 W metal film resistor	1 MΩ		2322 151 71005
R5	1 W metal film resistor	10 Ω		2322 153 51009

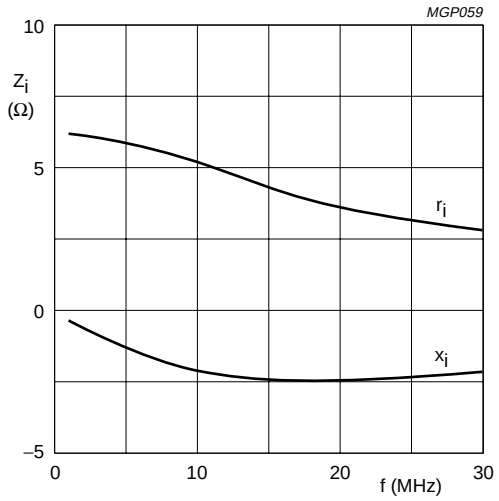
Notes

1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
2. The striplines are on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric (ε_r = 2.2), thickness 1.6 mm.



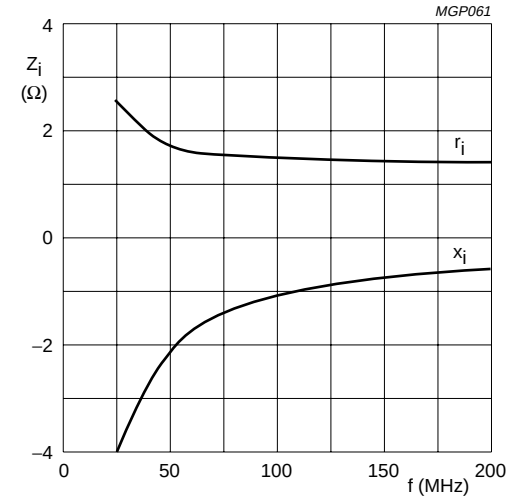
Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 6.25 Ω; P_L = 150 W (PEP); R_L = 2.1 Ω.

Fig.14 Power gain as a function of frequency; typical values.



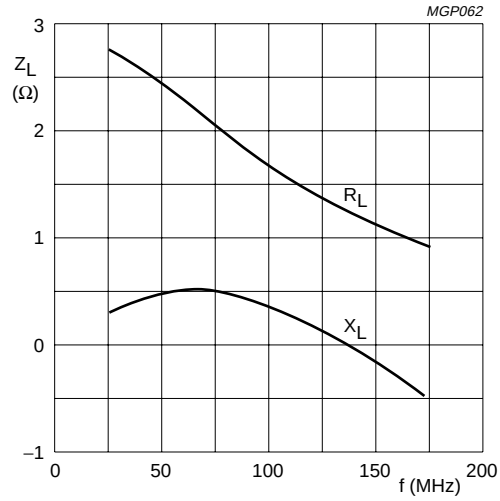
Class-AB operation; V_{DS} = 28 V; I_{DQ} = 1 A;
R_{GS} = 6.25 Ω; P_L = 150 W (PEP); R_L = 2.1 Ω.

Fig.15 Input impedance as a function of frequency (series components); typical values.



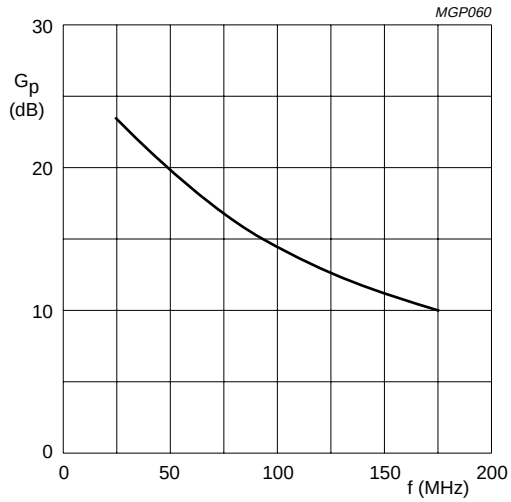
Class-B operation; V_{DS} = 28 V; I_{DQ} = 0.2 A;
R_{GS} = 15 Ω; P_L = 150 W.

Fig.16 Input impedance as a function of frequency (series components); typical values.



Class-B operation; V_{DS} = 28 V; I_{DQ} = 0.2 A;
R_{GS} = 15 Ω; P_L = 150 W.

Fig.17 Load impedance as a function of frequency (series components); typical values.



Class-B operation; V_{DS} = 28 V; I_{DQ} = 0.2 A;
R_{GS} = 15 Ω; P_L = 150 W.

Fig.18 Power gain as a function of frequency; typical values.

BLF147 scattering parameters

V_{DS} = 28 V; I_D = 1000 mA; note 1

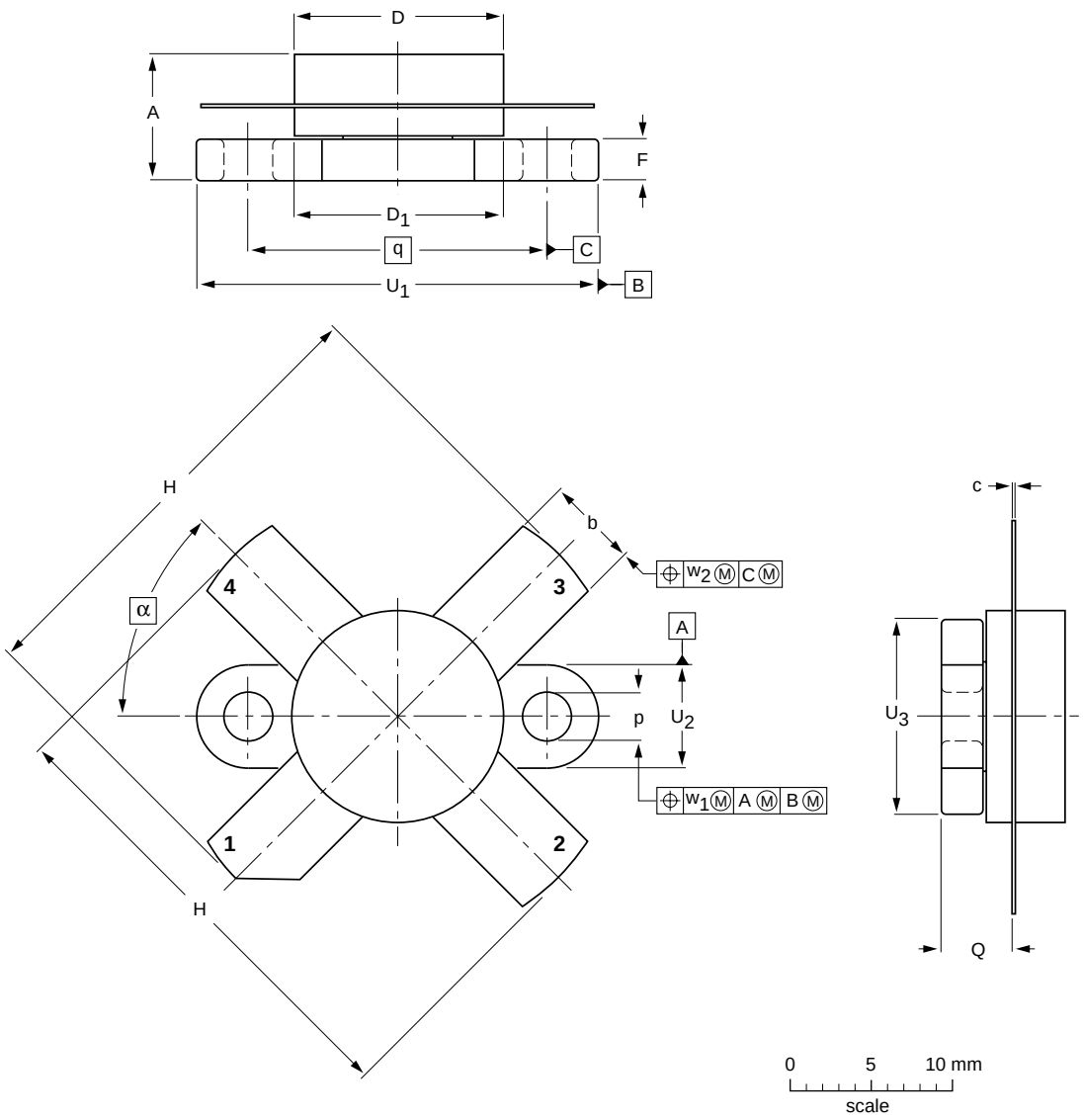
f (MHz)	s_{11}		s_{21}		s_{12}		s_{22}	
	$\|s_{11}\|$	$\angle\Phi$	$\|s_{21}\|$	$\angle\Phi$	$\|s_{12}\|$	$\angle\Phi$	$\|s_{22}\|$	$\angle\Phi$
5	0.91	–170.00	23.90	93.40	0.01	5.80	0.88	–171.20
10	0.91	–174.60	12.25	89.40	0.01	3.60	0.89	–177.20
20	0.92	–177.40	5.94	81.00	0.01	5.40	0.83	–179.60
30	0.92	–178.40	3.87	79.10	0.01	8.90	0.86	–178.90
40	0.92	–178.80	2.84	75.70	0.01	12.00	0.85	–178.60
50	0.92	–178.80	2.26	73.30	0.01	16.90	0.87	–176.90
60	0.92	–179.00	1.88	69.80	0.01	20.30	0.90	–177.30
70	0.93	–179.20	1.58	66.20	0.01	24.00	0.90	–178.10
80	0.93	–179.60	1.36	63.20	0.01	28.80	0.90	–178.40
90	0.93	–179.70	1.19	60.40	0.01	34.20	0.90	–178.60
100	0.94	–179.70	1.05	57.00	0.01	39.30	0.90	–179.40
125	0.95	179.50	0.77	49.30	0.01	52.30	0.88	179.20
150	0.95	179.00	0.60	45.80	0.01	64.90	0.91	–179.50
175	0.96	178.10	0.49	41.50	0.02	72.40	0.95	179.80
200	0.96	177.50	0.40	36.80	0.02	75.80	0.94	177.70
250	0.97	175.80	0.28	33.20	0.03	82.30	0.95	176.20
300	0.98	174.20	0.22	30.10	0.03	83.00	0.96	173.60
350	0.98	172.70	0.17	31.00	0.04	85.00	0.97	171.90
400	0.98	171.10	0.14	32.40	0.05	84.90	0.97	169.50
450	0.98	169.50	0.12	36.10	0.05	85.90	0.97	167.70
500	0.98	167.90	0.11	39.90	0.06	84.30	0.98	165.50
600	0.98	164.80	0.10	50.20	0.07	83.20	0.97	161.50
700	0.98	161.60	0.10	57.90	0.09	81.70	0.97	157.50
800	0.98	158.20	0.11	63.70	0.10	81.00	0.97	153.50
900	0.97	154.60	0.13	67.20	0.12	79.50	0.97	149.30
1000	0.97	151.10	0.14	70.20	0.14	78.80	0.96	144.90

Note

1. For more extensive S-parameters see internet:
   http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast.

PACKAGE OUTLINE

Flanged ceramic package; 2 mounting holes; 4 leads **SOT121B**



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	c	D	D_1	F	H	p	Q	q	U_1	U_2	U_3	w_1	w_2	α
mm	7.27 6.17	5.82 5.56	0.16 0.10	12.86 12.59	12.83 12.57	2.67 2.41	28.45 25.52	3.30 3.05	4.45 3.91	18.42	24.90 24.63	6.48 6.22	12.32 12.06	0.25	0.51	45°
inches	0.286 0.243	0.229 0.219	0.006 0.004	0.506 0.496	0.505 0.495	0.105 0.095	1.120 1.005	0.130 0.120	0.175 0.154	0.725	0.98 0.97	0.255 0.245	0.485 0.475	0.01	0.02	

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT121B						99-03-29

DATA SHEET STATUS

LEVEL	DATA SHEET STATUS(1)	PRODUCT STATUS(2)(3)	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

Notes

1. Please consult the most recently issued data sheet before initiating or completing a design.
2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

DEFINITIONS

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

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